

**Search Notes**

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Applicant(s)/Patent under  
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Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
349	update	5/31/2006	CHN

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	5/31/2006	CHN